

Dual N-Channel PowerTrench[®] MOSFET 30 V, 9.5 m Ω and 20 m Ω

Features

- Q1: N-Channel
- Max $r_{DS(on)} = 20 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 6 \text{ A}$
- Max $r_{DS(on)}$ = 32 m Ω at V_{GS} = 4.5 V, I_D = 5 A

Q2: N-Channel

- Max $r_{DS(on)}$ = 9.5 m Ω at V_{GS} = 10 V, I_D = 9 A
- Max $r_{DS(on)}$ = 13.5 m Ω at V_{GS} = 4.5 V, I_D = 7 A
- RoHS Compliant

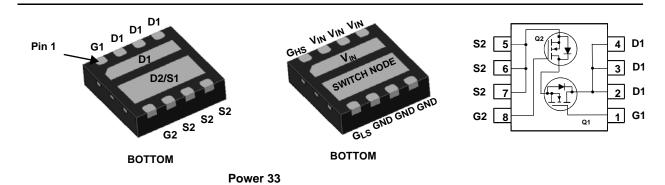


General Description

This device includes two specialized N-Channel MOSFETs in a dual Power33 (3mm x 3mm MLP) package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous MOSFET (Q2) have been designed to provide optimal power efficiency.

Applications

- Mobile Computing
- Mobile Internet Devices
- General Purpose Point of Load



MOSFET Maximum Ratings T_C = 25 °C unless otherwise noted

| Symbol | Parameter | | Q1 | Q2 | Units | |
|-----------------------------------|--|------------------------|-------------------|-------------------|-------|--|
| V _{DS} | Drain to Source Voltage | | 30 | 30 | V | |
| V _{GS} | Gate to Source Voltage | (Note 3) | ±20 | ±20 | V | |
| I _D | Drain Current - Continuous (Package limited) | T _C = 25 °C | 18 | 18 | | |
| | - Continuous (Silicon limited) | T _C = 25 °C | 23 | 45 | ٨ | |
| | - Continuous | T _A = 25 °C | 8 ^{1a} | 12 ^{1b} | Α | |
| | - Pulsed | | 40 | 40 | | |
| D | Power Dissipation | T _A = 25 °C | 1.9 ^{1a} | 2.2 ^{1b} | 14/ | |
| P _D | Power Dissipation | T _A = 25 °C | 0.7 ^{1c} | 0.9 ^{1d} | W | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to | +150 | °C | |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 65 ^{1a} | 55 ^{1b} | |
|---------------------|---|-------------------|-------------------|------|
| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction to Ambient | 180 ^{1c} | 145 ^{1d} | °C/W |
| $R_{	ext{	heta}JC}$ | Thermal Resistance, Junction to Case | 7.5 | 4 | |

Package Marking and Ordering Information

| [| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|---|----------------|----------|----------|-----------|------------|------------|
| | FDMC8200 | FDMC8200 | Power 33 | 13 " | 12 mm | 3000 units |

June 2014

| FDMC8200 |
|------------------|
| Dual |
| N-Channel |
| PowerTrei |
| nch® |
| MOSFET |

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units |
|--|---|---|------------------|-------------------|----------------|----------------|----------|
| Off Chara | cteristics | | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $ I_D = 250 \; \mu \text{A}, \; \text{V}_{\text{GS}} = 0 \; \text{V} \\ I_D = 250 \; \mu \text{A}, \; \text{V}_{\text{GS}} = 0 \; \text{V} $ | Q1 Q2 | 30 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 250 \ \mu$ A, referenced to 25 °C | Q1 Q2 | | 14 14 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ | Q1 Q2 | | | 1 1 | μA |
| I _{GSS} | Gate to Source Leakage Current | $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$ | Q1 Q2 | | | 100 100 | nA nA |
| On Chara | cteristics | | | | | | |
| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = 250 \ \mu A$ | Q1 Q2 | 1.0 1.0 | 2.3 2.3 | 3.0 3.0 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 250 \ \mu$ A, referenced to 25 °C | Q1 Q2 | | -5 -6 | | mV/°C |
| | $ \begin{array}{ c c c c c c c c } \hline V_{GS} = 10 \ V, \ I_D = 6 \ A \\ V_{GS} = 4.5 \ V, \ I_D = 5 \ A \\ V_{GS} = 10 \ V, \ I_D = 6 \ A, \ T_J = 125 \ ^\circ C \\ \hline V_{GS} = 10 \ V, \ I_D = 9 \ A \\ V_{GS} = 4.5 \ V, \ I_D = 7 \ A \\ V_{GS} = 10 \ V, \ I_D = 9 \ A, \ T_J = 125 \ ^\circ C \\ \hline \end{array} $ | $V_{GS} = 4.5 \text{ V}, \ I_D = 5 \text{ A}$ $V_{GS} = 10 \text{ V}, \ I_D = 6 \text{ A}, \ T_J = 125 \text{ °C}$ | Q1 | | 16 24 22 | 20 32 28 | mΩ |
| r _{DS(on)} | | | 7.3 9.5 10 | 9.5 13.5 13 | | | |
| 9 _{FS} | Forward Transconductance | $V_{DD} = 5 \text{ V}, \ I_D = 6 \text{ A}$ $V_{DD} = 5 \text{ V}, \ I_D = 9 \text{ A}$ | Q1 Q2 | | 29 56 | | S |
| Dynamic | Characteristics | | | | | | |
| C _{iss} | Input Capacitance | | Q1 Q2 | | 495 1180 | 660 1570 | pF |
| C _{oss} | Output Capacitance | V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ | Q1 Q2 | | 145 330 | 195 440 | pF |
| C _{rss} | Reverse Transfer Capacitance | - | Q1 Q2 | | 20 30 | 30 45 | pF |
| R _g | Gate Resistance | | Q1 Q2 | | 1.4 1.4 | | Ω |
| Switching | g Characteristics | | | | | | |
| t _{d(on)} | Turn-On Delay Time | Q1 | Q1 Q2 | | 11 13 | 20 23 | ns |
| t _r | Rise Time | V_{DD} = 15 V, I _D = 1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω | Q1 Q2 | | 3.1 4 | 10 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | Q2 V _{DD} = 15 V, I _D = 1 A, | Q1 Q2 | | 35 38 | 56 60 | ns |
| t _f | Fall Time | $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ | Q1 Q2 | | 1.3 6 | 10 12 | ns |

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Total Gate Charge

Total Gate Charge

Gate to Source Charge

Gate to Drain "Miller" Charge

Q_{g(TOT)}

 $Q_{g(TOT)}$

 Q_gs

 Q_{gd}

nC

nC

nC

nC

6

7.3

16

3.1

7

1.8

4.1

1

1.5

12

10

22

4.3

10

Q2

Q1

Q2

Q1

Q2

Q1

Q2

Q1

Q2

2

 $V_{GS} = 0 V$ to 10 V Q1:

 $V_{GS} = 0 V \text{ to } 4.5 V |_{I_D} = 6 \text{ A},$

Q2:

V_{DD} = 15 V, I_D = 9 A,

| FDMC8200 | |
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| I PowerTrenc | |
| h [®] MOSFE | |
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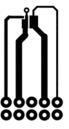
| Symbol | Parameter | Test Conditions | | Туре | Min | Тур | Max | Units |
|-----------------|---------------------------------------|---|--------------------|----------|-----|------------|------------|-------|
| Drain-So | urce Diode Characteristics | | | | | | | |
| V _{SD} | Source to Drain Diode Forward Voltage | 00 / 0 | lote 2) lote 2) | Q1 Q2 | | 0.8 0.8 | 1.2 1.2 | V |
| t _{rr} | Reverse Recovery Time | Q1 I _F = 6 A, di/dt = 100 A/s | | Q1 Q2 | | 13 21 | 24 34 | ns |
| Q _{rr} | Reverse Recovery Charge | Q2 I _F = 9 A, di/dt = 100 A/s | _ | Q1 Q2 | | 2.3 5.6 | 10 12 | nC |

Notes:

1. R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

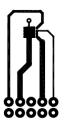


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c. 180 °C/W when mounted on a minimum pad of 2 oz copper

a.65 °C/W when mounted on a 1 in $^2\,$ pad of 2 oz copper



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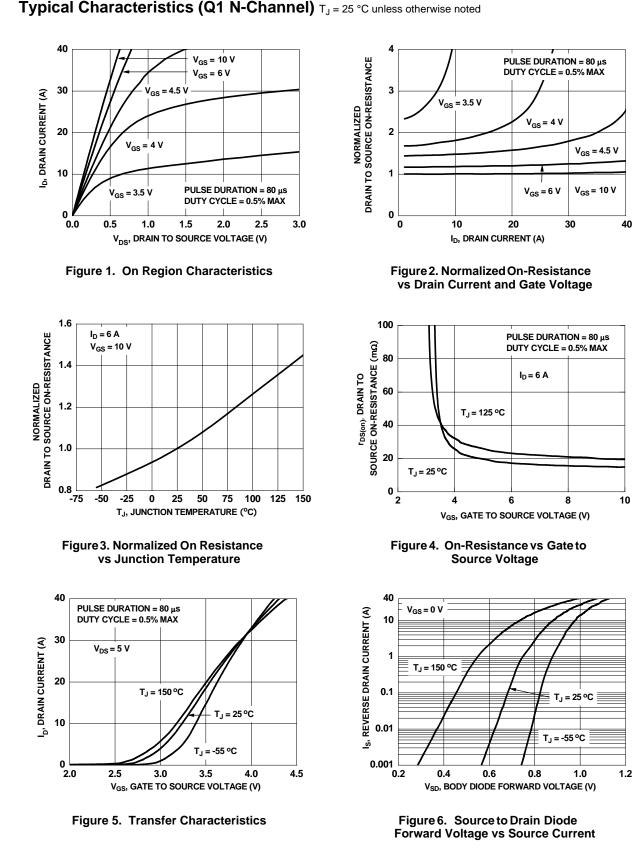
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d. 145 °C/W when mounted on a minimum pad of 2 oz copper

b.55 °C/W when mounted on a 1 in² pad of 2 oz copper

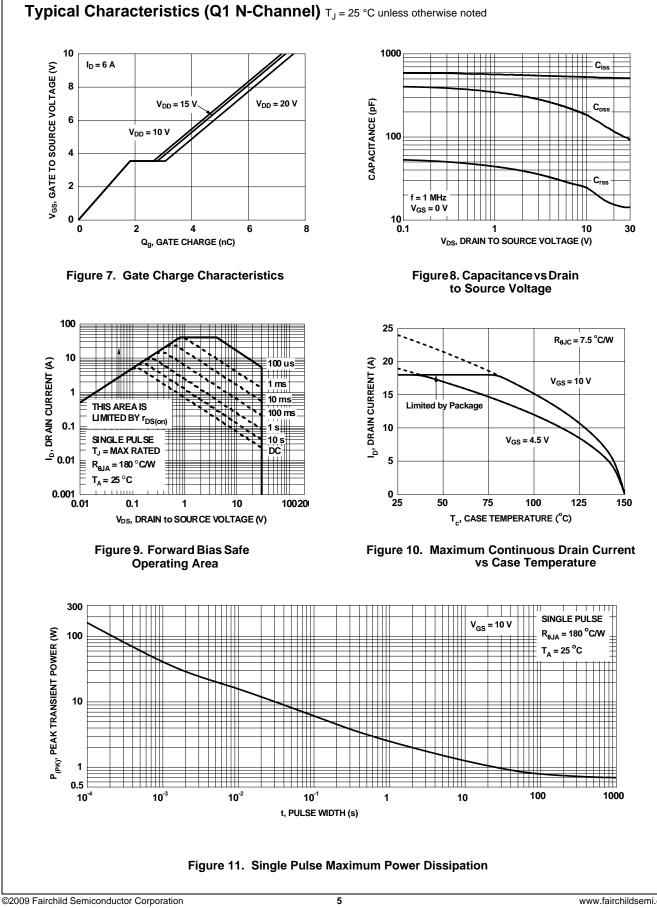
2. Pulse Test: Pulse Width < 300 $\mu \text{s},$ Duty cycle < 2.0%.

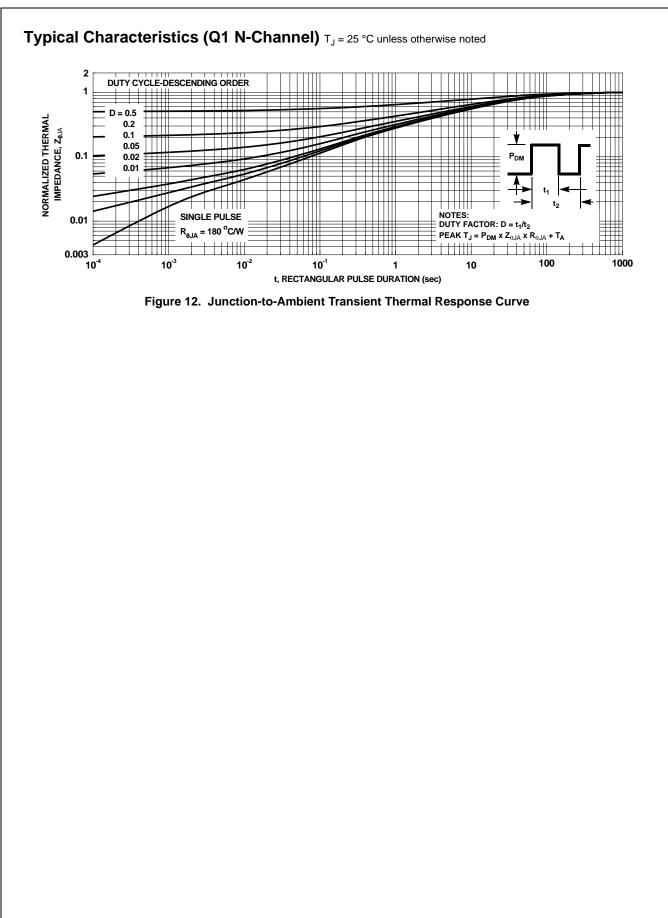
3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.



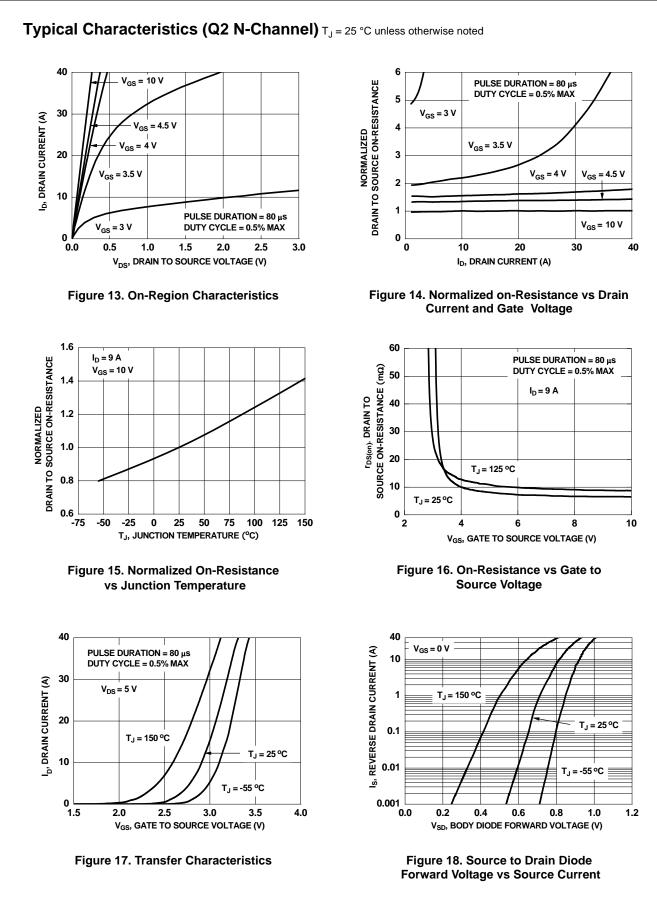
Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted



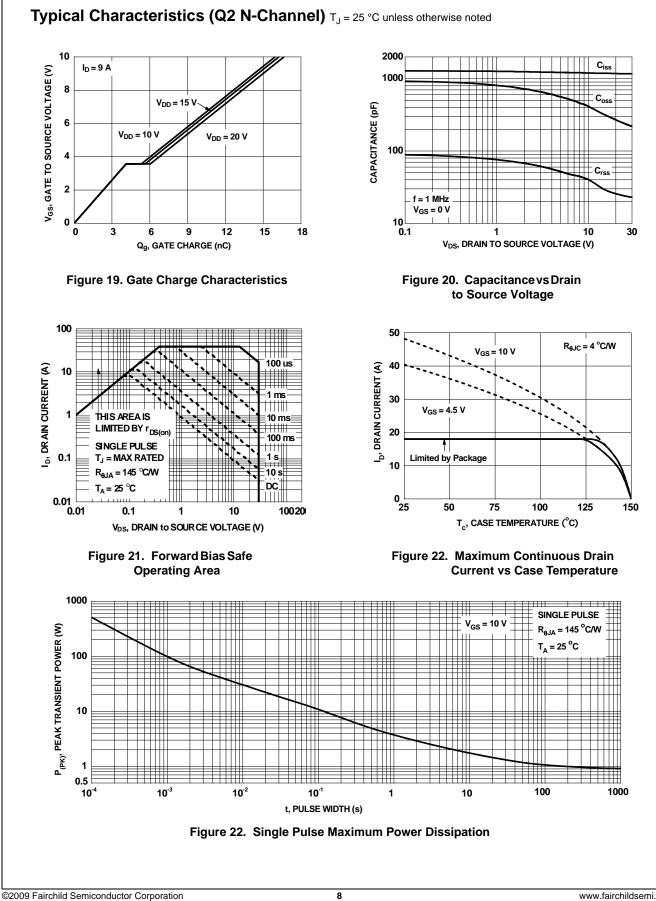




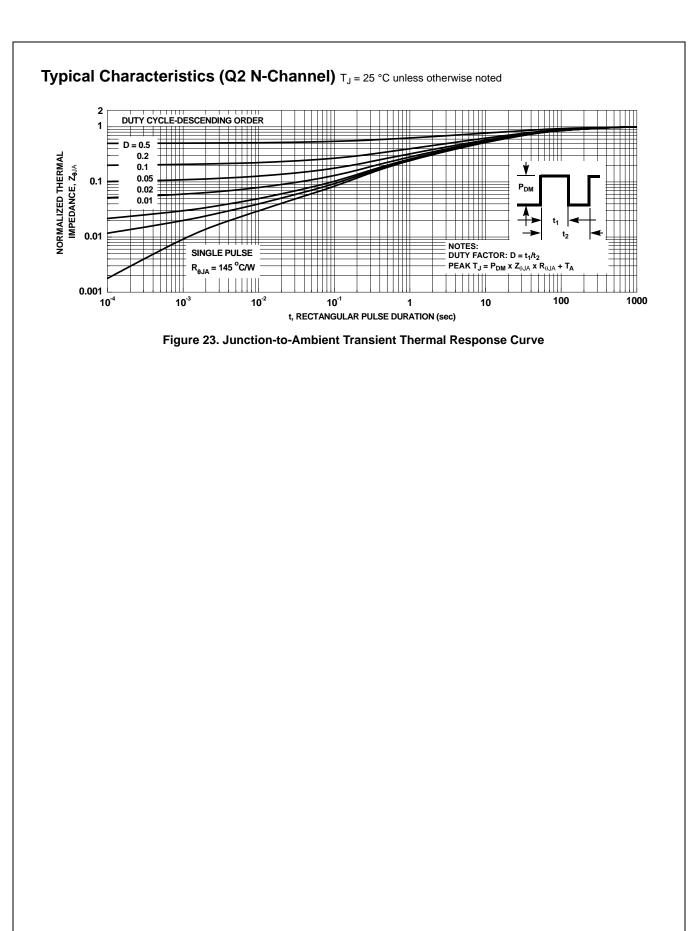
FDMC8200 Dual N-Channel PowerTrench® MOSFET

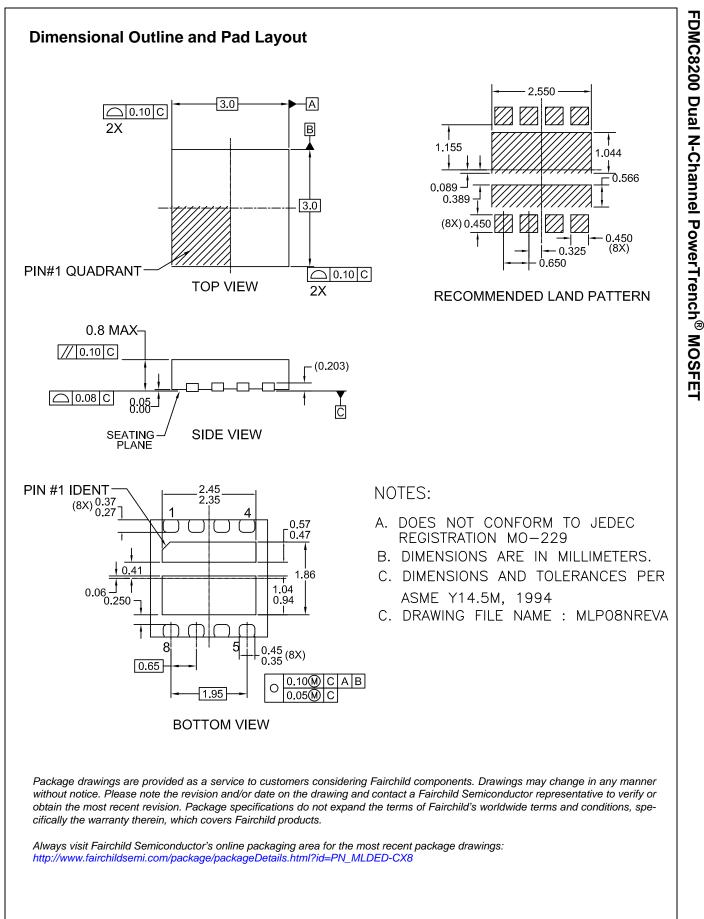
















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